

**Notice of References Cited**

Application/Control No.

09/217,633

Applicant(s)/Patent Under

Reexamination

NAKAMORI ET AL.

Examiner

Hien Tran

Art Unit

1764

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,177,960	01-1993	Hitachi et al.	422/180
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
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	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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**NON-PATENT DOCUMENTS**

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